Claims

What is claimed is:

5 1. A method of managing spatially related defects on a data storage media surface in a data storage device comprising:

identifying defect locations on the media surface;

determining whether the location of an identified defect is within a predetermined window of another identified defect location on the media surface;

if the location is within the predetermined window, characterizing the defects in the window as a scratch; and.

generating a scratch tracking table having a start index and an end index for each scratch.

- 2. The method according to claim 1 further comprising padding the scratch.
- 3. The method according to claim 1 wherein the characterizing operation comprises: assigning a unique scratch index to the scratch; and associating each defect within the window with the unique scratch index.
- 4. The method according to claim 3 further comprising: generating a scratch index table associating each identified defect with a scratch index.
 - 5. The method according to claim 1 wherein the determining operation comprises: loading an identified defect location in a register; and comparing the defect location and a last identified defect location of each identified scratch against predetermined window criteria.
 - 6. The method according to claim 7 wherein the predetermined window criteria comprises a number of cylinders and a number of bytes.

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7. A method comprising:

identifying defect locations on a data storage media; tabulating the identified defects in a defect list;

determining whether one or more defect locations lies within a predetermined window of another defect location;

assigning a unique scratch index to each defect location within the predetermined window;

generating a scratch tracking table listing a start index for a first defect location in the window and an end index for a last defect location in the window for each scratch index assigned; and

generating a scratch index table associating a scratch index with each defect location.

- 8. The method according to claim 7 further comprising:
 using the scratch tracking table and the scratch index table to determine whether a read or
 write command is to be redirected to another data storage media location.
- 9. The method according to claim 7 further comprising: retrieving an entry in the scratch tracking table having a first scratch index; searching the scratch index table for defect locations associated with the first scratch 20 index;

padding the scratch; and repeating the retrieving, searching and padding operations for a next scratch index.

10. The method according to claim 9 wherein the repeating operation includes a query operation asking whether an end of the scratch tracking table has been reached prior to retrieving the next scratch index.

- 11. A system for managing scratches on a data storage media in a data storage device comprising:
 - a controller adapted to control access by a host to and from the data storage media; a memory coupled to the controller;
- a scratch index table in the memory having a unique index entry for each identified defect location on the data storage media and an associated scratch index entry for each defect location; and;

a scratch tracking table in the memory having, for each scratch index entry, a start index, and end index, and an end defect location for each identified scratch index.

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- 12. The system according to claim 11 further comprising a buffer in the controller wherein the scratch tracking table and scratch index table are utilized in the buffer to identify defect locations.
 - 13. The system according to claim 11 further comprising:

an operational sequence for identifying defect locations on the media surface;

an operational sequence for determining whether the location of an identified defect is within a predetermined window of another identified defect location on the media surface;

an operational sequence for characterizing the defects in the window as a scratch, if the location is within the predetermined window; and.

an operational sequence for generating a scratch tracking table having a start index and an end index for each scratch.

- 14. The system according to claim 13 further comprising an operational sequence for padding each scratch in the scratch tracking table.
 - 15. The system according to claim 13 wherein the characterizing operational sequence comprises:

assigning a unique scratch index to the scratch; and associating each defect within the window with the unique scratch index.

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- 16. A data storage device comprising:
- a data storage medium;
- a controller coupled to the data storage medium;
- a plurality of sequences for generating and using a scratch tracking table and a scratch index table to characterize defects identified on the data storage medium as belonging to one or more identified scratches.
 - 17. The data storage device according to claim 16 further comprising a sequence for padding identified scratches on the medium.
 - 18. The data storage device according to claim 16 wherein a sequence for generating a scratch tracking table includes operations of:

identifying defect locations on the data storage medium;

tabulating the identified defects in a defect list;

determining whether one or more defect locations lies within a predetermined window of another defect location;

assigning a unique scratch index to each defect location within the predetermined window; and

generating the scratch tracking table listing a start index for a first defect location in the window and an end index for a last defect location in the window for each scratch index assigned.

- 19. The data storage device according to claim 18 further comprising a sequence for generating a scratch index table associating a scratch index with each defect location.
- 25 20. The data storage device according to claim 19 further comprising a sequence for padding each scratch listed in the scratch tracking table.